

L Number	Hits	Search Text	DB	Time stamp
-	2	((chang\$3 or generat\$3 or set) near (((input or output or I/O) near mode) or (number near2 data))) same (semi\$1conduct\$3 near memory)) same (test adj mode)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 16:26
-	12	((chang\$3 or generat\$3 or set) near (((input or output or I/O) near mode) or (number near2 data))) same (semi\$1conduct\$3 near memory)) same circuit	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 17:33
-	23815	test adj (mode or pin or terminal or pad)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 17:36
-	922	(test adj (mode or pin or terminal or pad)) same (high near2 voltage)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 17:39
-	201	((test adj (mode or pin or terminal or pad)) same (high near2 voltage)) same ((input or output or I/O) near4 circuit)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 17:46
-	17	((test adj (mode or pin or terminal or pad)) same (high near2 voltage)) same ((input or output or I/O) near4 circuit)) same (semi\$1conduct\$3 near memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 17:40
-	4341	(test adj (mode or pin or terminal or pad)) same ((input or output or I/O) near4 circuit)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 17:46
-	316	((test adj (mode or pin or terminal or pad)) same ((input or output or I/O) near4 circuit)) same (semi\$1conduct\$3 near memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 17:46
-	219	((test adj (mode or pin or terminal or pad)) same ((input or output or I/O) near4 circuit)) same (semi\$1conduct\$3 near memory)) and 365/\$.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 18:17
-	1006	(test adj mode) and (normal adj operation adj mode)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 18:20
-	417	((test adj mode) and (normal adj operation adj mode)) and (semi\$1conduct\$3 near memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 18:20
-	66	((test adj mode) and (normal adj operation adj mode)) and (semi\$1conduct\$3 near memory)) and (external adj signal\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 18:23
-	31	((test adj mode) and (normal adj operation adj mode)) and (semi\$1conduct\$3 near memory)) and (external adj signal\$1)) and pad\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 18:24
-	30	((test adj mode) and (normal adj operation adj mode)) and (semi\$1conduct\$3 near memory)) and (external adj signal\$1)) and pad\$1) and voltage	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/24 18:34

-	1006	(test adj mode) and (normal adj operation adj mode)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/24 18:37
-	685	(test adj mode) same (normal adj operation\$1 adj mode)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/06 11:30
-	13	((test adj mode) same (normal adj operation\$1 adj mode)) same (external adj signal\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/24 18:40
-	190	((test adj mode) same (normal adj operation\$1 adj mode)) same voltage	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/24 19:12
-	123	((test adj mode) same (normal adj operation\$1 adj mode)) same voltage) same signal\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/24 18:51
-	19	((test adj mode) same (normal adj operation\$1 adj mode)) same voltage) same signal\$1) same pad\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/24 19:11
-	11	((test adj mode) same (normal adj operation\$1 adj mode)) same voltage) same signal\$1) same pad\$1) and (power adj supply)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/24 19:08
-	70	((test adj mode) same (normal adj operation\$1 adj mode)) same (voltage near2 level)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/06 11:12
-	4	(test adj mode) same (normal adj operation\$1 adj mode) same (voltage near2 level) same signal\$1 same pad\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/06 11:10
-	172932	257/\$.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/06 11:12
-	0	((test adj mode) same (normal adj operation\$1 adj mode) same (voltage near2 level) same signal\$1 same pad\$1) and 257/\$.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/06 11:12
-	71	(test adj mode) same (normal adj operation\$1 adj mode) same (voltage near2 level)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/06 11:13
-	2	((test adj mode) same (normal adj operation\$1 adj mode) same (voltage near2 level)) and 257/\$.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/06 11:13
-	689	(test adj mode) same (normal adj operation\$1 adj mode)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/06 11:32

-	22	257/\$.ccls. and ((test adj mode) same (normal adj operation\$1 adj mode))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/06 11:32
---	----	---	---	------------------